OCT 0 2 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors:

Jiping Li; Peter G. Borden; Edgar B. Genio

Title:

High Throughput Measurement Of Via Defects In Interconnects

Serial No.:

10/813,407

Filing Date:

March 29, 2004

Examiner:

Trinh, Michael Manh

Group Art Unit:

2822

Docket No.:

BOX016 US

Confirmation No:

5642

Santa Clara, California October 2, 2005

Mail Stop AMENDMENT COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA VA 22313-1450

Second SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, §1.97 and §1.98, the Applicants submit for consideration the attached International Search Report and Written Opinion (11 pages total) in a PCT application which claims priority from the current application. Note that these papers were received on Sept 30, and hence no fee should be required. If a fee is required, please charge the deposit account 50-2263 and identify the charge by using the docket number BOX016 US.

The information contained in this Supplemental Information Disclosure Statement is to the best of my knowledge and is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

CERTIFICATE OF FACSIMILE TRANSMISSION

I hereby certify that this correspondence is being facsimile transmitted to the U.S. Patent and Trademark Office to the fax number 571-273-8300

on October 2, 2005.

Attorney for Applicant(s) Date of Signature

Respectfully submitted,

Omkar K. Suryadevara Attorney for Applicant(s)

Reg. No. 36,320

Application No. 10/813,407

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Sheet 1 of 1

Application No.:	10/813,407
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		U.S. Patent	Documents			
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	Other Art (In	cluding Author,	litle, Date, Pertinent I	Pages, Etc.)		
	International Search in	PCT/US05/0095	88, which claims prior	rity of US Appli	cation 10/813	407 (current
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	Written Opinion in PC	T/US05/009588,	which claims priority	of US Applicati	on 10/813,407	(current
	application)					
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Examiner:	Date Considered:				
* Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication with applicant.					
not in conformance and not considered. Include copy of this form	with your comments.				